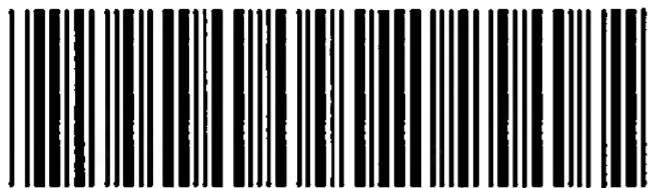


# Search Notes



Application/Control No.

10/624,386

Examiner

Matsuichiro Shimizu

Applicant(s)/Patent under Reexamination

FERNANDEZ, JORGE D.

Art Unit

2635

## SEARCHED

Class	Subclass	Date	Examiner
340	7.4 7.44 825.44	9/29/05	ms
340	825.16	↓	↓

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
340	7.4	9/29/05	ms

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
Exon 340 first, second, predetermined time, period monitor	9/29/05	ms
	↓	↓